

Search Notes

Application/Control No.

10/728,597

Examiner

Madeleine AV Nguyen

Applicant(s)/Patent under
Reexamination

ENMEI, TOSHIHARU

Art Unit

2626

SEARCHED

Class	Subclass	Date	Examiner
update		7/28/2005	AV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	7/28/2005	AV